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KEATING & BENNETT LLP

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**To:** Examiner Baumeister **From:** Joseph R. Keating

**Fax:** 703-872-9306 **Date:** March 8, 2004

**Phone:** 571-272-1722 **Pages:** 17

**Re:** 09/658,732 **CC:**

36856.919

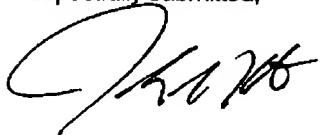
**Comments:**

Examiner Baumeister,

Please find attached hereto the following documents for the above-identified application:

- 1) Amendment;
- 2) Request for Continued Examination;
- 3) Petition for ONE-Month Extension of Time;
- 4) Information Disclosure Statement; and
- 5) Two Credit Card Forms PTO-2038.

Respectfully submitted,



Joseph R. Keating  
for  
Keating & Bennett, LLP  
(Registration Number 37,368)

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CERTIFICATE OF FACSIMILE TRANSMISSION

I hereby certify that this correspondence is being transmitted to Group Art Unit 2815, 703-872-9306, addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Date: March 8, 2004

Sonia V. McVean

Sonia V. McVean

PATENT  
36856.919

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Makoto INAI et al.	Art Unit: 2815
Serial No.: 09/658,732	
Filed: September 11, 2000	Examiner: B. Baumeister
Title: FIELD-EFFECT SEMICONDUCTOR DEVICE	

**REQUEST FOR RECONSIDERATION**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated June 11, 2003 and the Advisory Action dated December 2, 2003, the period for response to which has been extended to March 9, 2004, by the accompanying Petition for a ONE-month Extension of Time and the Notice of Appeal filed December 9, 2003, please reconsider the above identified application in view of the following remarks.

**A listing of the claims** begins on page 2 of this paper for the convenience of the Examiner. No amendments are being made by this listing.

**Remarks/Arguments** begin on page 6 of this paper.